

# Selecting Fluxes for Lead-Free Wave Soldering

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# Lead-Free Transition Experience

- Assemblers have been doing lead-free wave soldering for several years
- Majority of soldering has been on relatively simple assemblies
  - Consumer electronics
  - Single- or double-sided
  - Used original tin-lead flux
- Process settings not significantly different from tin-lead on relative simple boards

# Consortia, Research and Applications Findings

- 0.062” thick boards will experience a tighter process window.
- Preheats do not change that much; most systems are capable.
- Solder temp doesn't change that much.
- Barrel fill can sometimes be a challenge, especially with OSP.
- Debridging not quite as good as tin-lead.

# Moving to Higher Complexity

- Thicker boards increase hole fill challenges exponentially
- High layer counts and numerous ground connections increase hole fill challenge
- These conditions can also create preheat challenge
- Longer dwell times make debridging difficult
- Selective solder pallets can shield areas from preheat exposure, making problem worse

# Assemblers' Challenges With LF

*Alloy* – Decreased Wetting Speed  
**Increased Skips**

*Alloy* – Decreased Fluidity  
**Poor Hole-fill, Increased Bridging**

*Components/PCB's* –  
Increased oxidation/degradation  
**Increased Skips, Poor Hole-fill**

*Processing Parameters* –  
Increased (i) Pre-heat (ii) Alloy T (iii) Contact Time  
**Increased chance of flux burn out**

**Equipment  
Development**

**Chemistry  
Development**

**Alloy  
Development**

# When Selecting a Wave Flux

1. Understand the Classification method used by IPC for all fluxes
2. Understand basic formulation approaches and their effects on

- *Reliability*

- *Activity*

- *Residue levels and cosmetics*

and how they apply to the end-use of the electronic product

# IPC Classification

- J-STD-004A
  - Latest revision 2004
  - Classifies fluxes by composition and activity
  - Applies to all fluxes used in electronics assembly:
    - Paste
    - Liquid (wave & rework)
    - Cored wire
    - Cored or coated preforms

# J-STD-004A Classification

- First division: 4 composition categories:

Rosin	(RO)
Resin	(RE)
Organic	(OR)
Inorganic	(IN)



# J-STD-004A Classification

- Next division: 6 activity levels
  - 3 main activity levels:

L	Low or no flux/flux residue activity
M	Moderate flux/flux residue activity
H	High flux/flux residue activity

# J-STD-004A Classification

- Next division: 6 activity levels
  - 3 main activity levels
    - 2 subdivisions to indicate presence of halides (0= absent or 1= present):

L0

L1

M0

M1

H0

H1

# J-STD-004A Classification

- Result: 24 classifications
- Table taken directly from J-STD document
- Note: inorganic fluxes are not used in electronics assembly

<i>Flux Materials of Composition</i>	<i>Flux/Flux Residue Activity Levels</i>	<i>% Halide (by weight)</i>	<i>Flux Type</i>	<i>Flux Designator</i>
ROSI (RO)	Low	0.0%*	L0	ROLO
		< 0.5%	L1	ROL1
	Moderate	0.0%	M0	ROM0
		0.5-2.0%	M1	ROM1
	High	0.0%	H0	ROH0
		>2.0%	H1	ROH1
RESI (RE)	Low	0.0%	L0	RELO
		< 0.5%	L1	REL1
	Moderate	0.0%	M0	REM0
		0.5-2.0%	M1	REM1
	High	0.0%	H0	REH0
		>2.0%	H1	REH1
ORGI (OR)	Low	0.0%	L0	ORLO
		< 0.5%	L1	ORL1
	Moderate	0.0%	M0	ORM0
		0.5-2.0%	M1	ORM1
	High	0.0%	H0	ORH0
		>2.0%	H1	ORH1
INORGI (IN)	Low	0.0%	L0	INLO
		< 0.5%	L1	INL1
	Moderate	0.0%	M0	INM0
		0.5-2.0%	M1	INM1
	High	0.0%	H0	INH0
		>2.0%	H1	INH1

\* 0.0% is defined as <0.05% by weight

# Tests to Determine Activity Levels

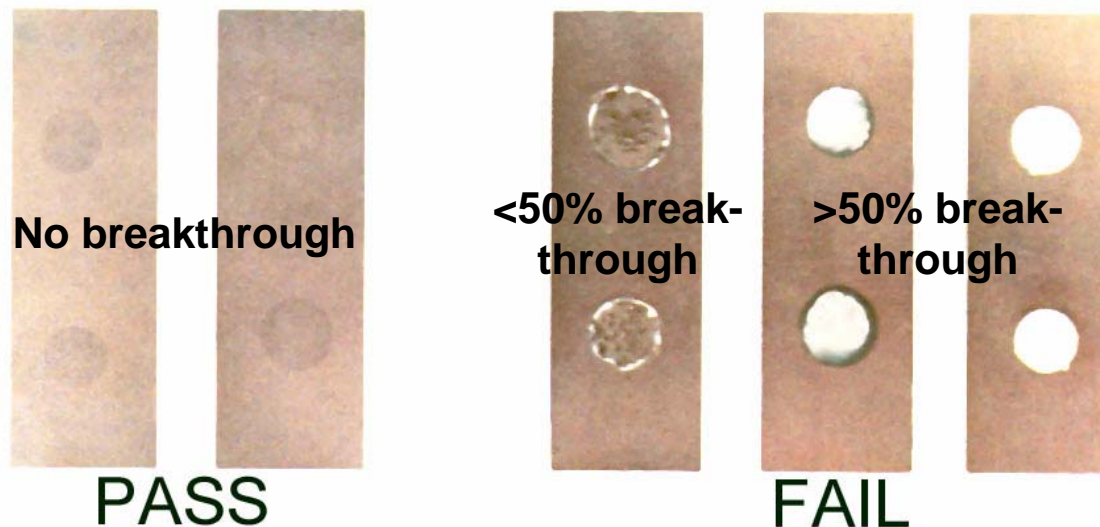
FLUX TYPE	COPPER MIRROR	QUALITATIVE HALIDE		QUANTITATIVE HALIDE	CORROSION TEST	CONDITIONS FOR PASSING 100 MEGOHM SIR REQUIREMENTS	CONDITIONS FOR PASSING ECM REQUIREMENTS
		SILVER CHROMATE (Cl, Br)	SPOT TEST (F)	(Cl, Br, F)			
L0	No evidence of mirror breakthrough	Pass	Pass	0.0%	No evidence of corrosion	Uncleaned	Uncleaned
L1		Pass	Pass	<0.5%			
M0	Breakthrough in < 50% of test area	Pass	Pass	0.0%	Minor corrosion acceptable	Cleaned or Uncleaned	Cleaned or Uncleaned
M1		Fail	Fail	0.5 to 2.0%			
H0	Breakthrough in > 50% of test area	Pass	Pass	0.0%	Major corrosion acceptable	Cleaned	Cleaned
H1		Fail	Fail	> 2.0%			

Source: J-STD-004A

# Activity Level Test Methods

- Copper Mirror Test

- Checks the removal effect of the flux on a thin copper deposit. A drop of test flux and a drop of control flux are placed on the copper mirror and conditioned at controlled room temperature for 24 hours. The results are observed and reported.



# Activity Level Test Methods

- Qualitative Halide
  - indicates absence or presence of halides. If no halides are detected, the quantitative halide tests are not necessary.
  - *Silver chromate* tests for chlorides and bromides
  - *Spot test* checks for fluorides
- Quantitative Halide
  - Ion chromatography

# Activity Level Test Methods

- Corrosion Test
  - Checks corrosiveness of flux's residue under extreme environmental conditions
- Surface Insulation Resistance (SIR)
  - Checks resistance of flux residues under high heat and humidity
- Electrochemical Migration (ECM)
  - Checks propensity of flux residues to allow ECM, such as dendritic growth

# Activity Levels

FLUX TYPE	COPPER MIRROR	QUALITATIVE HALIDE		QUANTITATIVE HALIDE	CORROSION TEST	CONDITIONS FOR PASSING 100 MEGOHM SIR REQUIREMENTS	CONDITIONS FOR PASSING ECM REQUIREMENTS
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M1		Fail	Fail	0.5 to 2.0%			
H0	Breakthrough in > 50% of test area	Pass	Pass	0.0%	Major corrosion acceptable	Cleaned	Cleaned
H1		Fail	Fail	> 2.0%			



# J-STD-004A Summary

- Classifies fluxes based on composition:  
RO (rosin), RE (resin), OR (organic)
- Subclassifies based on activity,  
L (low), M (medium), H (high)
- And halide content:  
0 (absent), 1 (present)
- Examples:  
ROL0, ORM0, REL1

# J-STD-004A Summary

- Provides classification methods and test methods to determine classification
- We now need guidance on how to select a particular class of flux for a given application.
- Understanding the different formulation options and end uses helps us select the right flux product.

# Flux Formulation Categories



# Definitions

## Alcohol Based

The carrier or solvent which holds all of the other active ingredients in solution for application to PCB

## Water Based

### + 'S

- Easy to dissolve ingredients
- Good surface wetting
- Easy to drive off in preheat

### - 'S

- Flammability Risk
- VOC Emissions

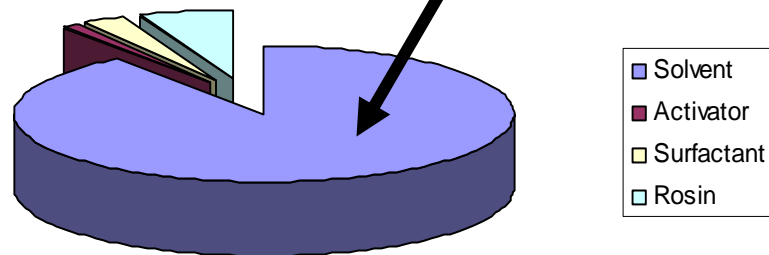
### + 'S

- No fire risk
- Vast VOC content reduction

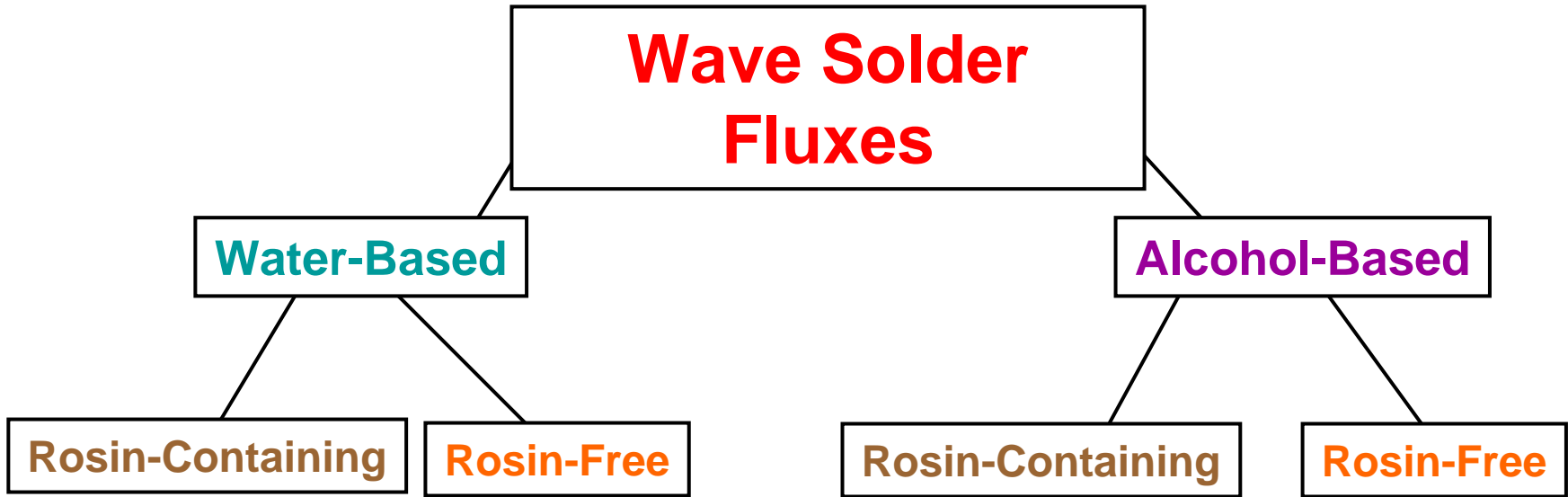
### - 'S

- Higher surface tension
- Lower solvency
- Harder to drive off in preheat

WAVE SOLDER FLUX



# Flux Formulation Categories



# Definitions

**Rosin Free**

Rosin inclusion determines the nature of the residue and can act to safely encapsulate any un-reacted acid after soldering

**Rosin Containing**

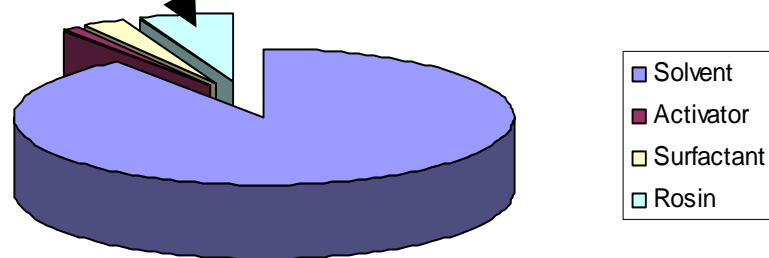
## **+ 'S**

Lowest possible residue levels  
Best cosmetics  
Best for pin testability

## **- 'S**

Need very good process control  
Potential reliability hazard in wrong environment/laminate combination

WAVE SOLDER FLUX



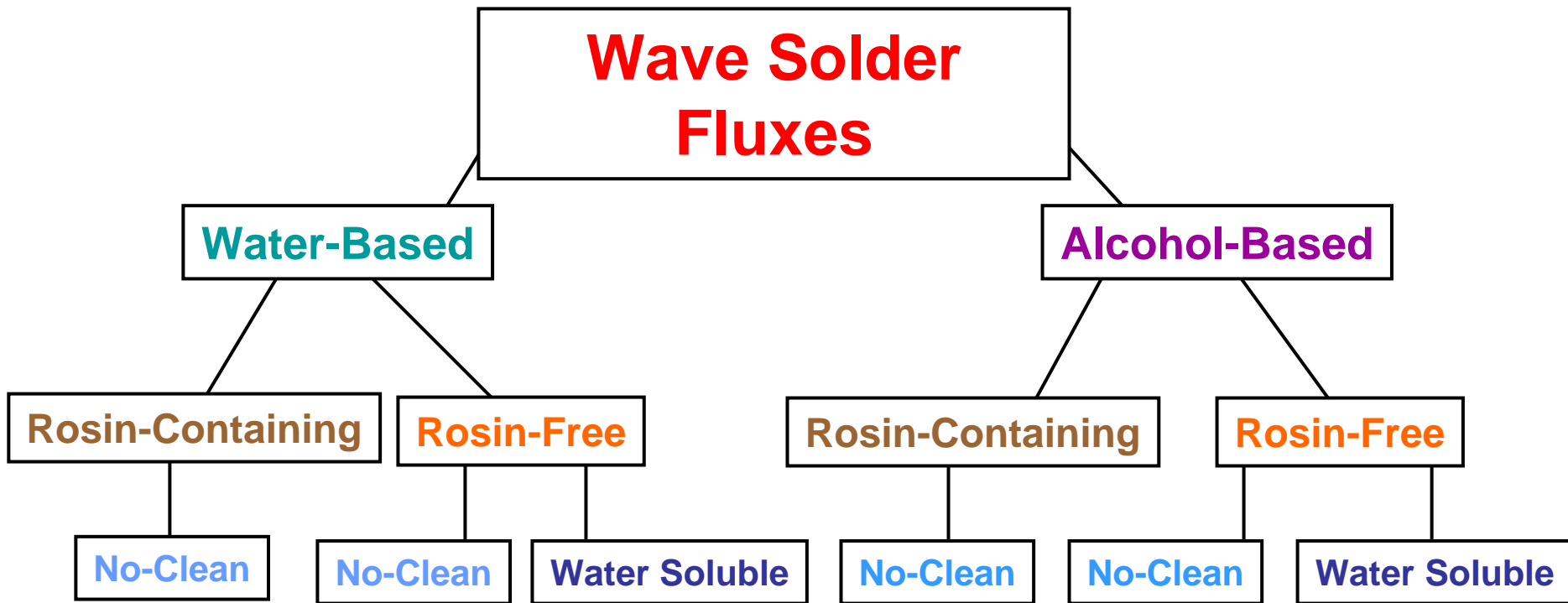
## **+ 'S**

Allows greater activity with maintained reliability for all laminates

## **- 'S**

More visible residue  
Reduced pin testability

# Flux Formulation Categories



# Definitions

No-Clean

Water Soluble Fluxes are corrosive after soldering and must be cleaned. Most fluxes can be left on the circuit board hence the term 'no-clean'\*

Water Soluble

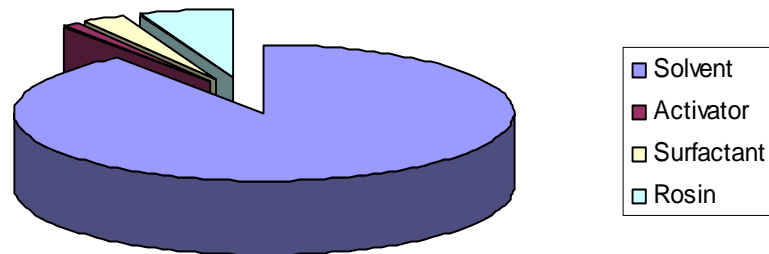
**+ 'S**

Minimize process steps

**- 'S**

Activity levels are limited by need for post soldering reliability

WAVE SOLDER FLUX



**+ 'S**

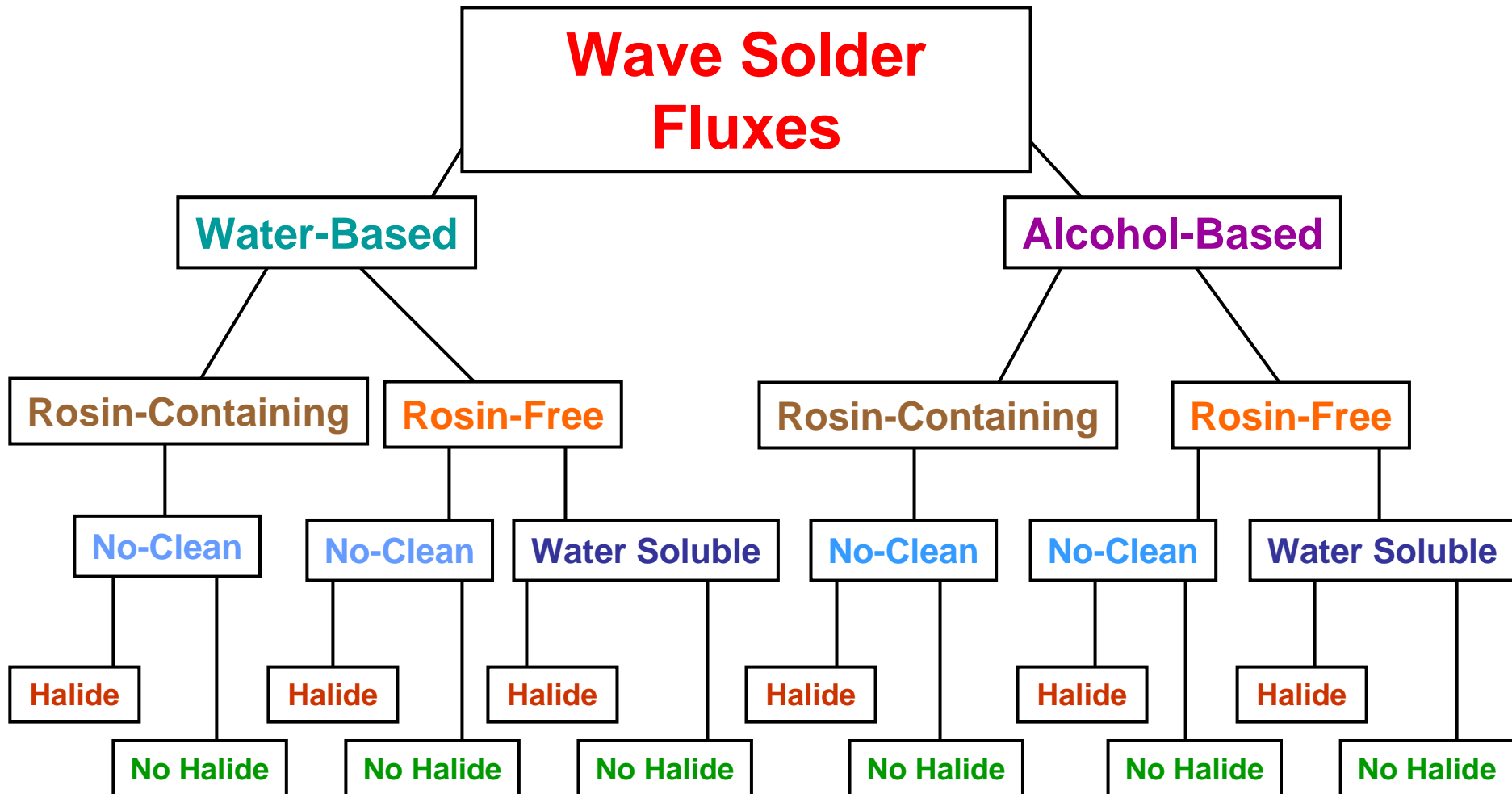
Activity not as limited for formulator

**- 'S**

Cleaning process must be robust  
Cleaning process adds cost



# Flux Formulation Categories



# Definitions

**Halide**

Halides are often used as activators because of their reactivity and ability to rapidly reduce metal oxides. However, other non-halide options are effective as activators

**No-Halide**

**+ 'S**

Use as a high performance activator type

**- 'S**

Can be the cause of post soldering corrosion

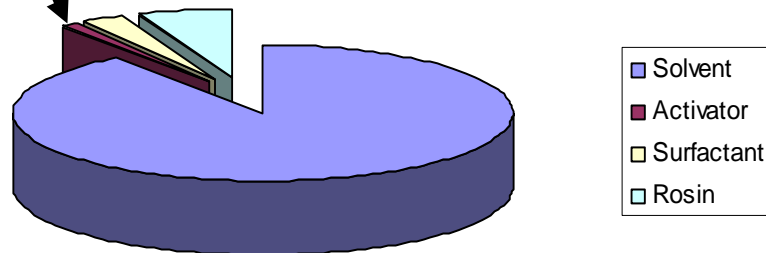
**+ 'S**

Perceived as safer

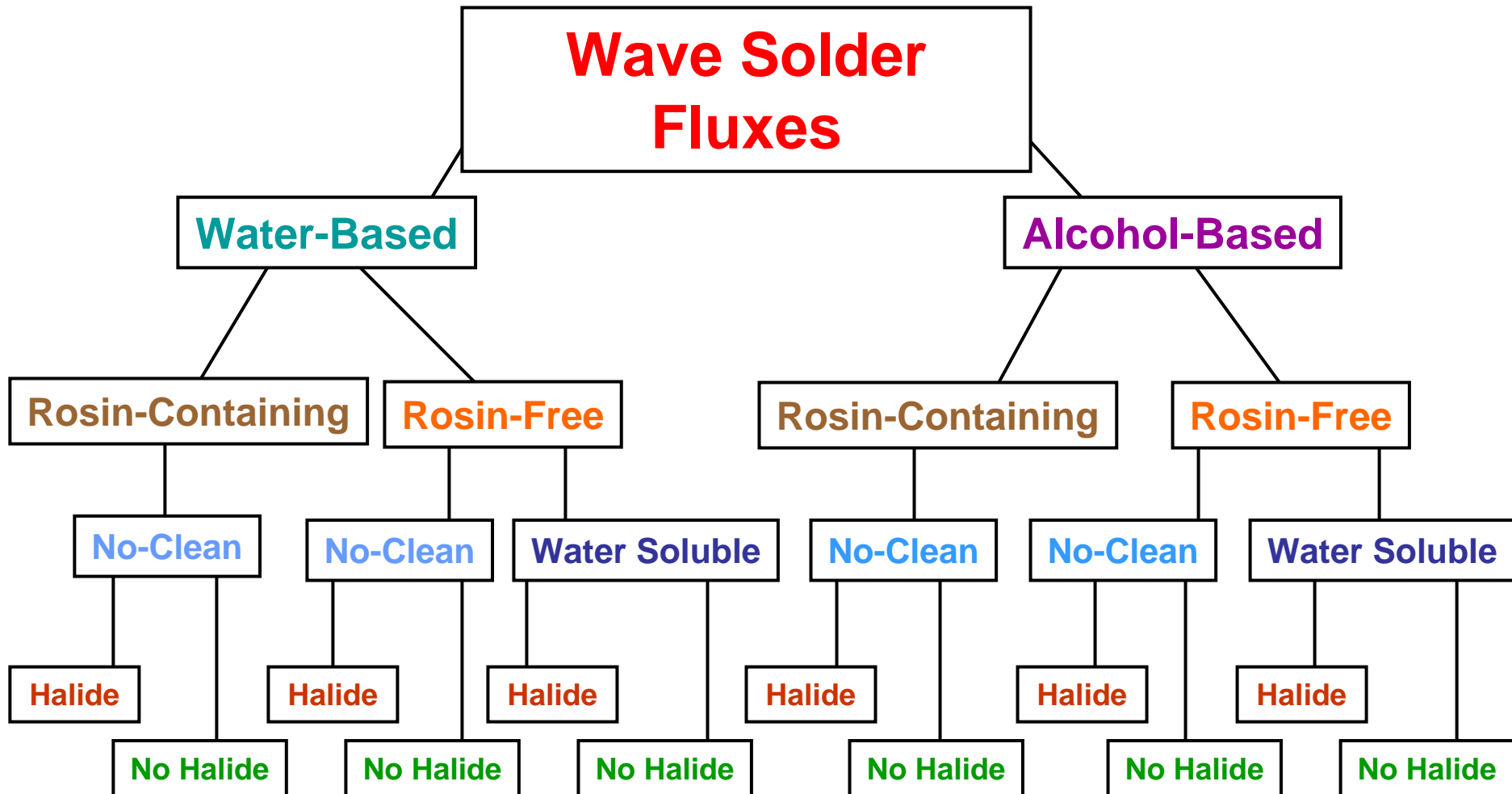
**- 'S**

Generally less active with poorer wetting performance

WAVE SOLDER FLUX



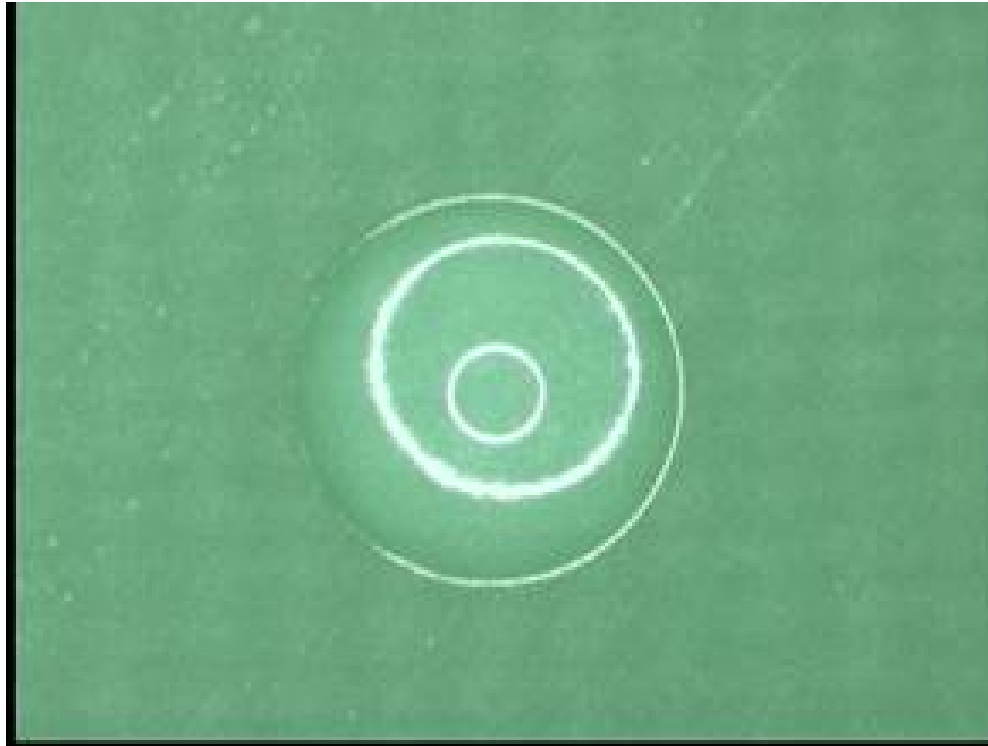
# Flux Formulation Categories



# Other Formulation Considerations

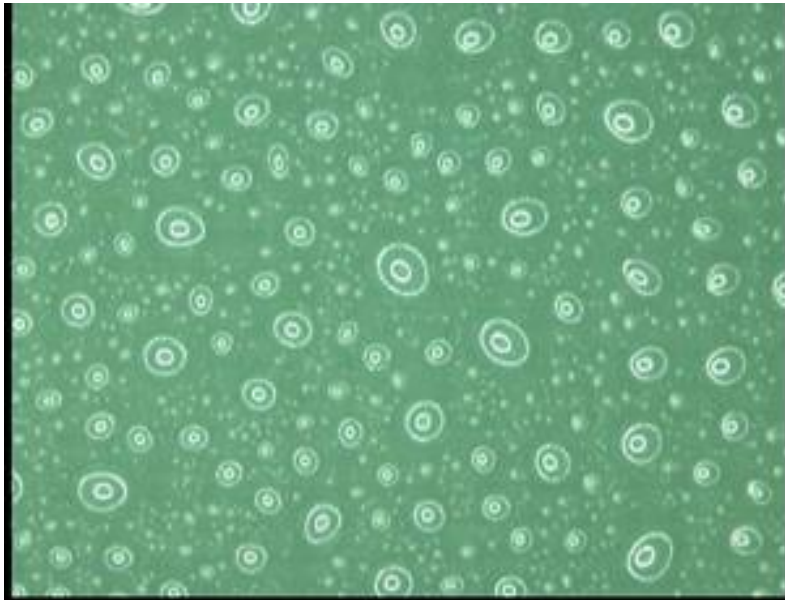
- Surfactants
- Extended thermal and soldering cycles
- Acid Number
- Reliability

# Surface Tension and Surfactants



A single drop of DI water on a commonly used solder mask  
We tried a drop of IPA but it spread too fast to photograph

# The Effect of Surface Tension on Spread



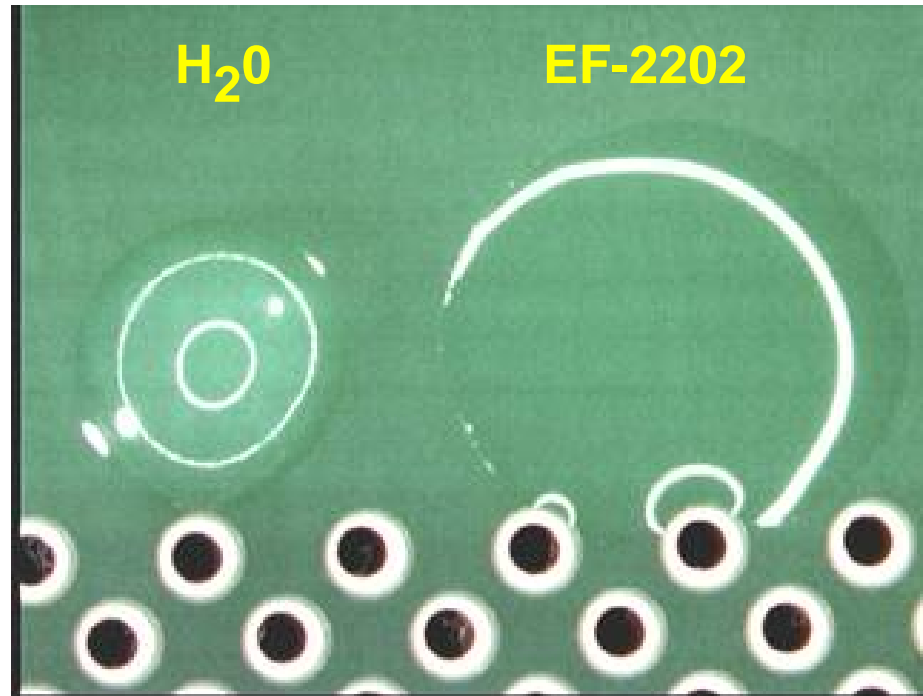
DI H<sub>2</sub>O – 73 dynes/cm



IPA –23 dynes/cm

Photograph captured immediately after spraying

# The Role of Surfactants



The drop of liquid on the left is DI water and the one on the right is water-based flux, whose surface tension was modified by surfactants.

# Extended Soldering Cycles

- Thick or thermally dense boards require longer contact times.
- Longer contact times typically require slower conveyor speeds.
- Slower conveyor speeds create longer preheat times also.
- Fluxes must be able to stand up to longer preheat cycles, longer wave contact, and higher wave temperatures



# Same No-Clean Flux for Tin-Lead and Lead-Free?

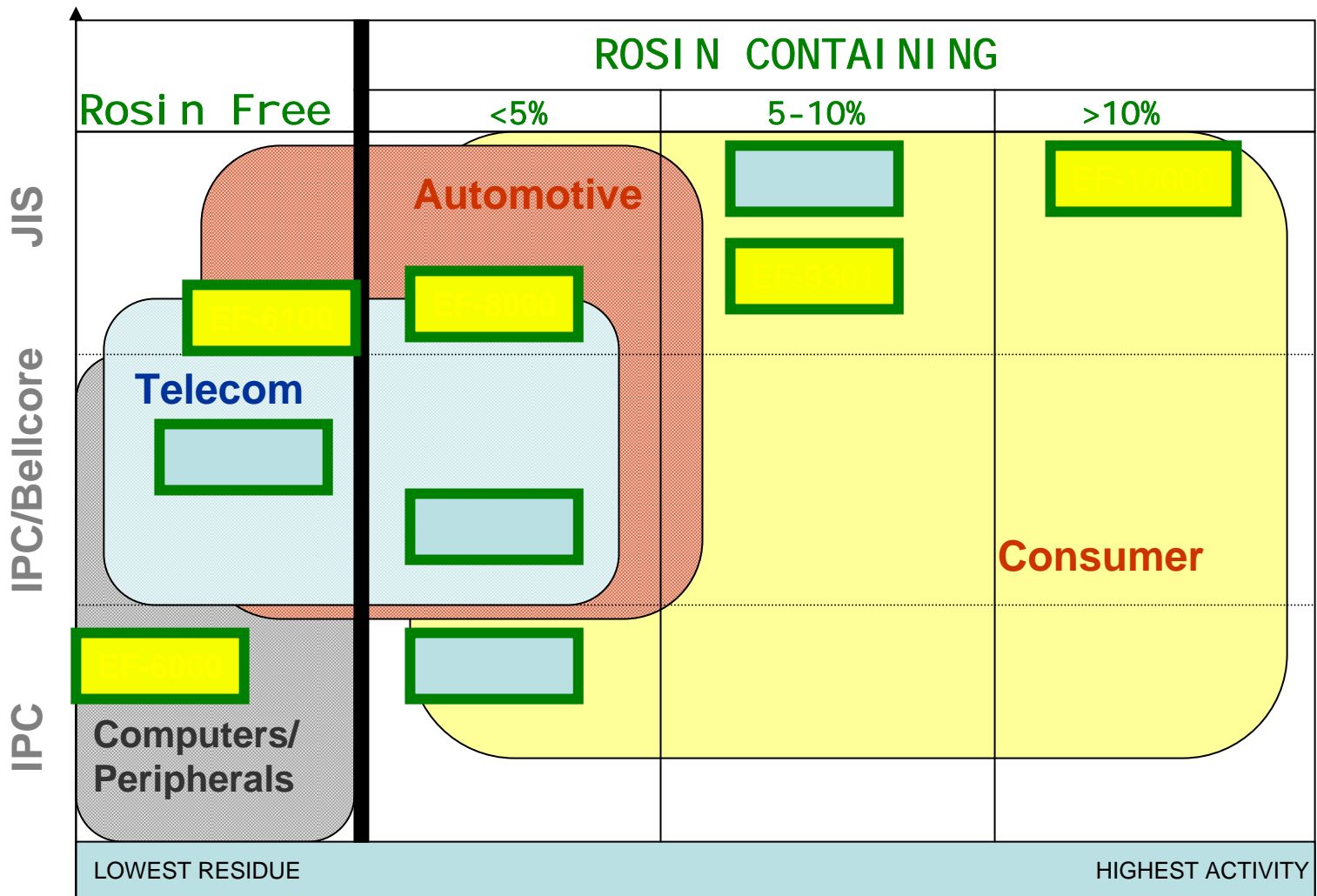
- Requires a delicate balance:
  - Relatively faster, cooler tin-lead thermal excursions must fully activate flux to maintain reliability
  - Activity must sustain the longer, hotter thermal excursions associated with lead-free processing
- Cooler processes bring reliability concern; hotter processes bring activity concern

# Acid Number

- Traditionally used as an indicator of a flux's activity
- No always true anymore
- Some fluxes with high acid number are not thermally stable and burn off early in lead-free process
- Some fluxes with low acid number have other ingredients that help them perform better than high acid number fluxes
- Can no longer be used as a primary indicator

# Reliability

- Tests in order of increasing difficulty
  - IPC SIR
    - Telcordia (Bellcore) SIR
      - Telcordia Electromigration
        - » JIS (typically only rosin-bearing fluxes pass this test)



Water Based Lead-Free Capable

Alcohol Based Lead-Free Capable

# Factors in Flux Selection

- Performance environment/reliability
- Assembly Complexity
- Residue levels and cosmetics
- Geographic location
  - Some areas limit VOC emissions, limiting flux choices to water-based only

# Assembly Complexity

- IPC Joint Industry Standards classify assemblies by their performance environments:

## **Class 1 - General Electronic Products**

Includes products suitable for applications where the major requirement is function of the completed assembly.

- Included here would be home consumer electronic products, appliances, toys.

# Assembly Complexity

## **Class 2 - Dedicated Service Electronic Products**

- This includes products where continued performance and extended life is required, and for which uninterrupted service is desired, but not critical. Typically the end-use environment would not cause failures.
- Included here would typically be computers, industrial and telecommunications equipment, and automotive electronics (except for engine management, drive-train and safety-related components.)

# Assembly Complexity

## **Class 3 - High Performance Electronic Products**

- This encompasses products where continued high performance or performance-on-demand is critical, equipment downtime cannot be tolerated, end-use environment may be uncommonly harsh, and the equipment must function when required.
- This would typically include military weapon and defense systems, aerospace, life support systems and under-the-hood automotive electronics.



# Example of Class 1 Application

- **Home Consumer Electronics**
  - Low cost components & boards
  - Paper-phenolic laminates (FR-2)
  - Low complexity
  - Not the best component solderability
  - Visible residues acceptable
- **Best Flux Choice:**
  - Alcohol-based, rosin-bearing, often including halides
  - Classified ROL0, REL0, ROM0, REM0 without halides
  - Classified ROL1, REL1, ROM1, REM1 with halides

# Another Class I Application

- Consumer electronics with higher functionality are using FR-4 laminates
- Rosin is no longer required to insure reliability
- Component solderability still an issue
- Best flux choice may be organic
  - ORL0 or ORM0
- Notice there is no ORL1 or ORM1
  - Without the encapsulation effect of the rosin, inclusion of halides would present long-term reliability issues: a *“recipe for disaster”*

# Example of Class 2 Application

- **IT/Telecom Infrastructure**

- Highest complexity assemblies
- Prior SMT thermal excursions
- Thermally dense – high component and layer count
- FR-4 laminate
- Visible residues not well tolerated

- **Best Flux Choice:**

- Water- or Alcohol-based, rosin-free, medium activity fluxes
- Water-based may be preferred to withstand long preheat cycles
- Classified ORL0 and ORM0

\* OR-- category fluxes should not be used on FR-2 laminates

# Example of Class 3 Application

- **Automotive**
  - Moderate complexity
  - Conservative designs
  - Typically 1.6mm FR-4, max 8 layers
  - May carry high voltage in harsh environments
  - Typically manufactured with good process control
- **Best Flux Choice:**
  - Alcohol-based, rosin-bearing, halide-free
  - Classified ROL0, ROM0, REL0, or REM0

# Summary

- J-STD-004A provides classification method
- No “One size fits all” single best flux
- Fluxes must be selected based on performance environment (reliability), assembly complexity, and residue levels
- User must understand relationships among assembly type, soldering process, and flux formulation to make educated decision.

**Thank You**

***Questions***

